CRITICAL ETEMS LIST

ASSY. NOMENCLATURE CCTV/LIVC

ASSY. F/N _2000744261

FATTURE FFFFCT								1
NAME, QTY & DRAWINGS REF. DESIGNATION	FUNCTION	FAILURE MODE AND CAUSE	END TIEM	INTERFACE	HISSION	CREW/ VEHICLE	RATIONALE FOR ACCEPTANCE	DATE
ITVC, I. Elbow Stack 20007442G1 ITVC 3.8.1	2/2	Thermostat does not close or an open strip heater. Thermostat	Degrada- tion of camera video until self- heating of circuitry restores normal opera- tion.	Na Video	l	l	See Sheet 2	
			Morst Case: Optical elements below minimum Lempera- ture. Loss of Mission Critical Video					

DESIGN FEATURES

the LTVC is comprised of 20 electrical subassemblies: 13 subassemblies are Lockheed Martin Astro Space designed and fabricated using standard printed circuit board type. construction. The remaining six assemblies, 3 stepper motors, High Vallage Pawer Supply (HMPS), Intensified CCD (ICCO), and Lens assembly are vendor supplied componorts, which have been specified and purchased according to Lockheed Martin Specification Control Oranings (SCOs) prepared by Engineering and Product Assurance. Specifications per the SCD are performance, test. qualification, and acceptance requirements for a procured piece of equipment. Parts, materials, processes, and design guidelines for the CTVC program are specified in accordance with Lockheed Hartin 3267828. This document defines the propram requirements.

MIL-SID-9756 will serve as the primary EEE parts selection document. If a suitable part cannot be found in MII-SID-9756, equivalent EEE parts that meet the following criteria may be substituted.

Microcircuits are at least Class B Level. MH-M-38510 devices. All microcircuits are subjected to Particle Impact Moise Detection (PIND) testing per MH-SID-8830 (except for devices with plastic epoxytype package).

Diodes and transistors are at least JANTXV in accordance with NLL-5-19500. All semi-conductors in cavity-type packages are subjected to PINO testing per MIL-510-093C.

DESIGN FEATURES (Cont.)

Relays are produced to the highest military established reliability (MI1-ER) level as defined in HTL-R-39016. Relays are subject to PINO testing.

Switches are procured to at least the second highest level of the appropriate NII-FR specification. Switches are subjected to either PIND testing or X-ray analysis as appropriate, for particle detection.

Other discrete parts are procured to at least the second highest level of the appropriate MCL-ER specification.

Parts not included in the above documents have been used in the design only after a non-standard parts acceptance request (NSPAR) has been prepared, submitted to Reliability Assurance Engineering and approved for use in the specific application(s) defined in the MSPAR by NASA-JSC.

Morst case circuit analyses have been performed and documented for all circuit designs to demonstrate that sufficient operating margins exist (or all operating conditions. The analysis was worst case in that the value for each of the variable parameters was set to limits that will drive the output to a maximum (or min.) A component approach review and analysis was conducted to verify that the applied stress on each piece part by the temperature extremes identified with environmental qualification testing does not exceed the stress derating values identified in torkheed Hartin 3267820.

DUSIGN FRATURES (Cont.)

In addition, an objective examination of the design was performed through a freliminary Design Review and Critical Design Review to verify that the ITVC met specification and contractual requirements.

BARE BOARD DESIGN All breads are con

All boards are constructed from laminated copper-clad apoxy glass sheets per HII-P-13949 Type GF Grade A. Circuit connections are made through printed traces which run from point to point on the board surfaces. Every trace terminates at an annular ring. The annular ring surrounds the hole in which a component lead or terminal is located. This ring provides a footing for the solder, ensuring good mechanical and electrical performance. Its size and shape are governed by MIL-P-55640. as are trace widths, spacing and routing. These requirements are reiterated specifically in drawing notes to further assure compliance. Variations between the artwork master and the final product Idue to irregularities of the eiching process) are also controlled by drawing notes. This prevents making defective boards from good artwork. Hules which house no lead or terminal, but serve unly to electrically interconnect the different board layers. contain stitch bars for mechanical support and increased reliability.

The through holes are drilled from a drill tape thus eliminating the possibility of buman error and allowing tight control over hole and annular ring concentricity, an important reliability criterion. After drilling and elching, all copper cladding

RATIONALE FOR ACCEPTANCE. (Continued)

MARE BOARD DESIGN (Cont.)
is tin-lead plated per MIL-SID-1495. This
provides for easy and reliable soldering
at the time of hoord assembly, even after
periods of prolunged storage.

DOARD ASSEMBLY DESIGN

All components are installed to a manner which assures maximum reliability. Component leads are pre-tioned, allowing total welting of solder joints. All leads are formed to provide stress relief and the hodies of large components are staked. Special mounting and handling instructions are included in each drawing required after final assembly. The board is coated with prethane which protects against humidity and contamination.

ACCEPTANCE TEST

Each assembly is individually tested to a NASA approved Acceptance Test Procedure TP-AT-20007442. The Acceptance Test Flow is detailed in attached Table 1.

OUALIFICATION TEST

The Qualification unit is identical to the flight unit configuration in every respect and is used solely for the purpose of qualification testing. The Qual unit must successfully complete acceptance testing prior to entering qualification testing. The Qual unit has passed testing in accordance with NASA approved test plan PN-C-2000/442. The Qualification Test Flow is detailed in attached Table 2.

UPERATIONAL_TESTS

In order to verify that CCIV components are operational, a lest must verify the health of all the command related components from the PUS (A7A) panel switch, through the RCU, through the sync lines to the Camera/PTU, to the Camera/PTU command decoder. The test must also verify the camera's ability to produce video, the YSU's ability to route video, and the monitor's ability to display video. A similar test would be performed to verify the MDN command path.

Pre-Launch on Orbiter Test/In-[light Test

- 1. Power CCTV System.
- Via the PNS panel, select a monitor as destination and the camera undor test as source.
- Send "Camera Power On" command from the PHS panel.
- 4. Select "External Sync" on monitor,
- 5. Observe video displayed on monitor. Note that if video on monitor is synchronized (i.e., stable raster) then this indicates that the camera is receiving composite sync from the RCH and that the camera is producing synchronized video.
- Send Pan. Fill, Focus, Zoom, ALC, and Gomma commands and visually (either via the monitor or direct observation) verify operation.
- Select downlink as destination and camera under test as source.
- 6. Observe video routed to downlink.
- Send "Camera Power Off" command via PMS panel.
- Repeat Steps 3 through 9 except issue commands via the MON command path.

OA/INSPECTION

<u>Procurement Control</u> - The LIVE EEE Parts and hardware items are procured from approved vendors and suppliers, which meet the requirements set forth in the LIVE contract. Resident DPRO personnel review all procurement documents to establish the need for GSI on selected parts (PAI S17).

Incoming Inspection and Storage - Incoming Quality tospections are made on all received materials and parts. Results are recorded by lot and retained in file by drawing and control numbers for future reference and traceability. All EEE parts are subjected to incoming acceptance tests as called for in PAP A4.14 - Incoming Inspection Test Instructions. Incoming flight marts are further processed in accordance with Lockhood Martin 3267828. Hechanical items are inspected per PAP A4.14 - Supplier Quality Assurance, and PAP E1D.B.1 - Procedure for Processing Incoming or Purchased Parts Designated for Flight Use. Accepted items are delivered to Material Controlled Stores and retained under specified conditions until fabrication is required. Non-conforming materials are hold for Haterial Review Board (MRB) disposition. (PAP A4.14.)

Noard Assembly & Test - Prior to the start of TVC hoard assembly, all items are verified to be correct by stock room personnel, as the blems are accumulated to form a kit. The items are verified again by the operator who assembles the kit by checking against the as-huilt-purts-list (ADPL). OPRO Handatory Inspection Points are designed for all

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QAZINSPECTION (Cont.)

printed circuit, plus harness connectors for soldering wiring, crimping, solder splices and quality workmanship prior to coating of the component side of boards and sleeving of harnesses.

QA/ENSPECTION (Cont.)

TIVE Boards

Specific ITVC board assembly and test instructions are provided in drawing notes. and applicable documents are called out in the Fabrication Procedure and Record (FPR-2000/442) and parts list Pt20007442. These include Process Standard-Monding RTV-556 2280081, Process Standard - Bonding Veloro Tape 22808B9, Specification Soldering 2280749, Specification - Crimping 2280800. Specification - Dooding and Staking 2280078, Specification - Urethane coating 2200077, Specification - Marking 2280876, Specification - Morkmanship 8030035, Specification Hunding and Staking 2200875, Specification-Wave Solder 2280821. Specification-Printed Wire Board Staking 2200051, Specification-Reflow Soldering 2200754, Specification-Soldering Surface Mount Components 20005710.

QAZINSPECTION (Cant.)

ITVC Assembly and Test

An open box test is performed per IP-II-20007442 and an Acceptance Test per IP-AI-20007442, including vibration and thermal vacuum. Torques are specified and witnessed, traceability numbers are recorded and calibrated tools are checked prior to use. Lockheed Martin Quality and DPRO inspections are performed at the completion of specified FPR operations in accordance with PAP-2.6.1, PAP-7.9, PAP-2.11, PAP-E6 1, and PAP-8.5. DPRO personnel witness ITVC button-up and critical torquing.

The ITVC is packaged according to NASA documents MHB6000.IC and MHB5300.4(ID2) which defines packaging and handling requirements. All related documentation including assembly drawings, Parts List, ABPL, Test Data, etc., is gathered and held in a documentation folder assigned specifically to each assembly. This fulder is retained for reference. An EIDP is prepared for each assembly in accordance with the requirements of PAP E2.3. Lockheed Harlin QC and UPRO personnel witness crating, packaging, packing, and marking, and review the EIDP for completeness and accuracy.

TABLE 1. ACCEPTANCE FEST FLOW

1. ROOM AMBIENT PERFORMANCE FEST

lest conducted per the requirements of MASA upproved 1P-A(-20007442.

2. ACCEPTANCE VIBRATION EXPOSURE

20-80 Hz: 3 dB/ogtave rise (rom 0.01 g²/Hz to 0.04 g²/Hz

80-350 Hz: 0.04 u2/Hz

350-2000 Hz: 3 d8/octave decrease to 0.005 g^2/Hz Test Duration: 1 minute/axis, operating Test Level: 6.1 grms

POS1-VIBRATION FUNCTIONAL CHECK

Test conducted per the requirements of MASA approved IP-AT-20007442.

4. ACCEPTANCE THERMAL-VACUUM EXPOSURE

1.5 cycles total from +)15 deg E to +14 deg E. After stabilization, one hour minimum duration at each plateau. In-spec functional tests performed at each plateau.

POST-ENVIRONMENTAL PERFORMANCE TEST

Room ambient performance tests conducted in accordance with NASA approved IP-AT-20007442.

TABLE 2. QUALIFICATION TEST FLOW

I. EM

Conducted tests run in accordance with the requirements of St-E-0002B, including C50). CS02, CS06, 1101, CCD3, and CE03, Radiated tests run in accordance with \$L-E-DODZB including RSO2, RSO3, and REO2 except that the Lest current for RSO2 was 2 amps in lieu of 20 ampş.

2. QUAL FOR ACCEPTANCE VIBRATION

20-80 Hz: 3 dH/octave increasing to 0.067 a^2/Hz

80-350 Uz: 0.067/octave

350-2000 Hz: 3 dB/octave decrease

Test Level: 7.8 gras

Test Ouration: 5 minutes/axis operation

3. FLIGHT QUALIFICATION YURALIUN

20-70 Hz: 0 dB/ogtave increasing to 0.4 g²/Hz

70-500 Hz: 0.4 g²/Hz:

500-2000 Hz; 6 dH/octave decrease

Fest Level: 18.1 grms

Test Duration: 40 minutes/axis non-operating

IJJERMAL-YACUUH

7.5 cycles total from +120 deg F to +9 deg F. After stabilization, one hour minimum duration at each plateau. In-spec functional tests performed at each plateau.

5. IMERHAL SUMULATION

Worst case hot and cold mission environments simulated in vacuum. During hot case, in-spec operation is required for 6 of 14 consecutive. hours. Ouring cold case, in-spec operation is required for 14 consecutive hours.

6. DUMIDITY

120 hours exposure to 85% RH including four 24 hour temperature cycles of +60 deg F to +125 deg t. non-operating.